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Gond.

and

a third chamber sapable of taking said substrate out of said multi-chamber system after depositing said gate insulating film.

86. (Amended) A multi-chamber system comprising:

a first chamber for irradiating a laser light to a semiconductor film formed over a substrate;

a means for introducing an oxidizing atmosphere into said first chamber;

a second chamber for depositing a gate insulating film on said semiconductor film;

a third chamber capable of taking said substrate out of said multi-chamber system after depositing said gate insulating film; and

a means for transporting said substrate among said first, second and third chambers.

92. (Amended) A multi-chamber system comprising:

a first chamber for irradiating a laser light to a semiconductor film formed over a substrate;

a means for introducing an oxidizing atmosphere into said first chamber;

a second chamber for depositing a gate insulating film; and

a third chamber for putting said substrate in said multi-chamber system and for taking said substrate out of said multi-chamber system,

wherein said multi-chamber system is capable of depositing said gate insulating film on said semiconductor film irradiated with said laser light.

98. (Amended) A multi-chamber system comprising:

a first chamber for irradiating a laser light to a semiconductor film formed over a



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substrate;

a means for introducing an oxidizing atmosphere into said first chamber;

a second chamber for depositing a gate insulating film;

a third chamber for putting said substrate in said multi-chamber system and for taking said substrate out of said multi-chamber system; and

a means for transperting said substrate among said first, second and third chambers, wherein said multi-chamber system is capable of depositing said gate insulating film on said semiconductor film irradiated with said laser light.

Please add new claims 136-153 as follows:

--136. (New) A multi-chamber system according to claim 80 wherein said means for introducing said oxidizing gas is a gas intake valve.

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- 137. (New) A multi-chamber system according to claim 86 wherein said means for introducing said oxidizing gas is a gas intake valve.
- 138. (New) A multi-chamber system according to claim 92 wherein said means for introducing said oxidizing gas is a gas intake valve.
- 139. (New) A multi-chamber system according to claim 98 wherein said means for introducing said oxidizing gas is a gas intake valve.
 - 140. (New) A multi-chamber system comprising:
 - a first chamber for irradiating a laser light to a semiconductor film formed over a

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substrate;

a means for introducing an oxidizing atmosphere into said first chamber;

a second chamber for depositing an insulating film on said semiconductor film; and

a third chamber gapable of taking said substrate out of said multi-chamber system.

141. (New) A multi-chamber system according to claim 140 wherein said second

chamber is selected from the group consisting of a plasma CVD apparatus, a low pressure

CVD apparatus, an atmospheric pressure CVD apparatus and a sputtering film formation

apparatus.

142. (New) A multi-chamber system according to claim 141 wherein a silicon oxide

film is formed by one of said apparatus.

143. (New) A multi-chamber system according to claim 140 wherein said laser

comprises an excimer laser or a YAO laser.

144. (New) A multi-chamber system according to claim 140 wherein said laser light

has a rectangular shape on an irradiating surface.

145. (New) A multi-chamber system according to claim 140 wherein said oxidizing

atmosphere comprises oxygen.

146. (New) A multi-chamber system according to claim 140 wherein said means for

introducing said oxidizing gas is a gas intake valve.

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147. (New) A multi-changer system comprising:

a first chamber for irradiating a laser light to a semiconductor film formed over a substrate;

a means for introducing an oxidizing atmosphere into said first chamber;

a second chamber for depositing an insulating film on said semiconductor film; and

a third chamber for putting said substrate in said multi-chamber system and for

taking said substrate out of said mula-chamber system.

148. (New) A multi-chamber system according to claim 147 wherein said second

chamber is selected from the group consisting of a plasma CVD apparatus, a low pressure

CVD apparatus, an atmospheric pressure CVD apparatus and a sputtering film formation

apparatus.

149. (New) A multi-chamber system according to claim 148 wherein a silicon oxide

film is formed by one of said apparatus.

150. (New) A multi-chamber system according to claim 147 wherein said laser

comprises an excimer laser or a YAG laser.

151. (New) A multi-chamber system according to claim 147 wherein said laser light

has a rectangular shape on an irradiating surface.

152. (New) A multi-chamber system according to claim 147 wherein said oxidizing

atmosphere comprises oxygen

Cont.